

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10572589	YAMAUCHI ET AL.
Examiner	Art Unit	
SHIN-HON CHEN	2431	

SEARCHED

Class	Subclass	Date	Examiner
726	26-30	6/10/09	S.C.
705	51, 57, 59, 26	6/10/09	S.C.

SEARCH NOTES

Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	6/10/09	S.C.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner